

Utility/Lab Workshop on PV Technology and Systems

November 8-9, 2010

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NREL/PR-5200-49854



Survey of PV Field Experience

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NREL

Outline

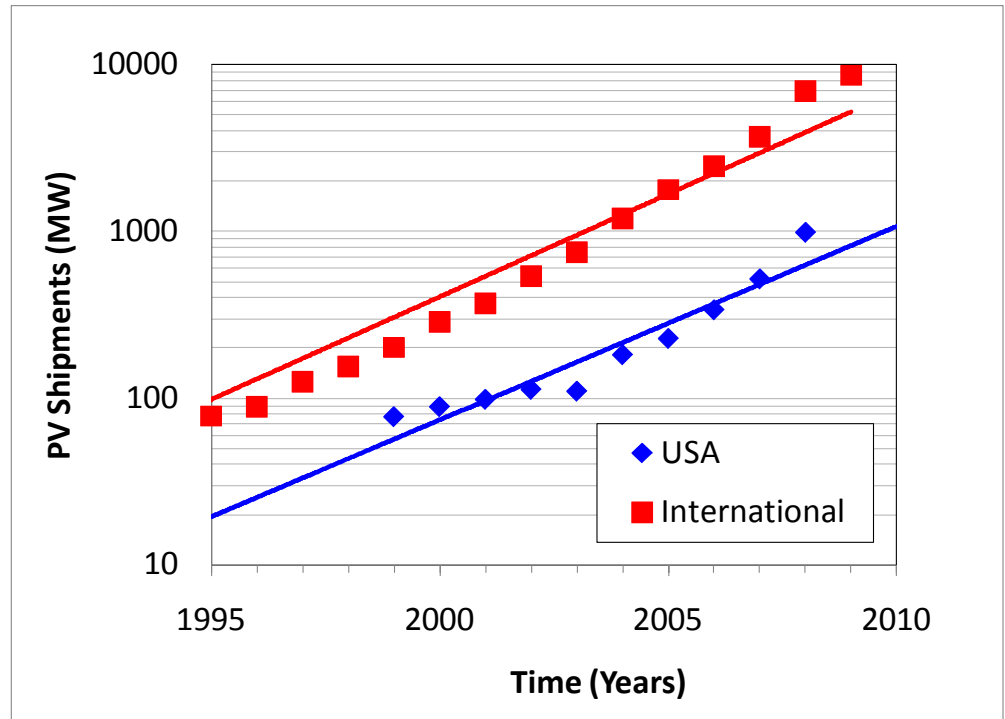
- ◆ Introduction
- ◆ Historical component failures
20 years ago – Modules ; Today - Inverters
- ◆ Historical degradation rates (R_d)
Most modules degrade at 0.5%/year & are improving
- ◆ Connection Degradation rate uncertainty & risk
Higher uncertainty leading to higher risk

Growth of PV Industry



Photo credit: Steve Wilcox, NREL PIX 15548

Alamosa Plant in Colorado



Sources:

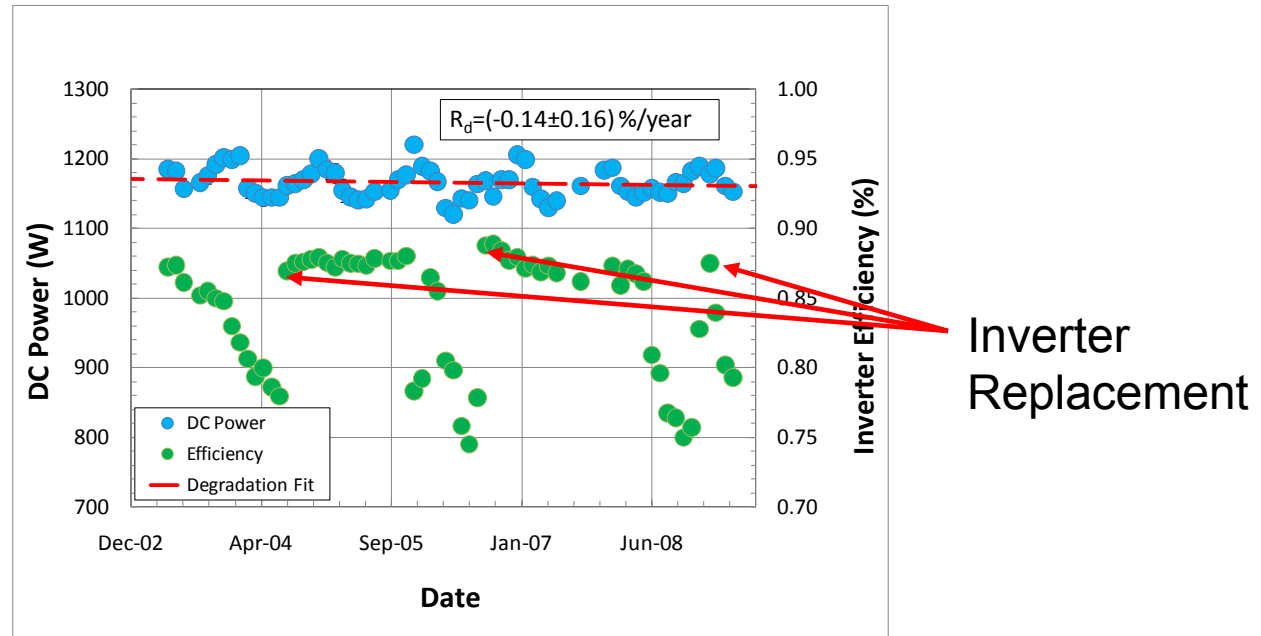
International: PV News, April 2009

USA: <http://www.eia.doe.gov/emeu/international/contents.html>

Reliability required to sustain exponential growth of industry

Reliability & Durability

- ◆ **Reliability:** Ability to perform designed task without failure → discrete, disruptive events
- ◆ **Durability:** Ability to perform task without significant deterioration → continuous, gradual decline



Extreme example of inverter failure

Both important for cost of electricity

PV for Utility Scale Application (PVUSA)

The plant was originally constructed by the Atlantic Richfield oil company (ARCO) in 1983.

Provided electricity, research opportunity, data & experience through the 1980s and 1990s.

Plant was dismantled in the late 1990s.

Location: Carrisa Plains
Size: 5.2 MW
Data: 1988

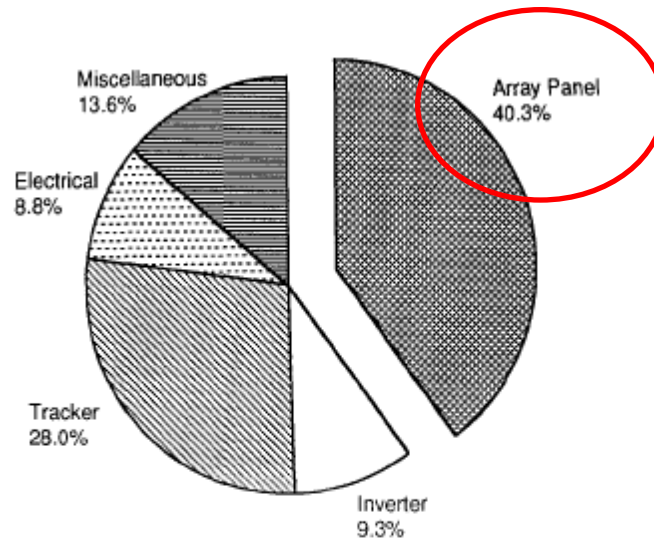


Figure 7. Maintenance labor hours, 1988. Percent of 3,100 total labor hours allocated by plant subsystem.

Plant contained engineering modules.

Some Research Publications

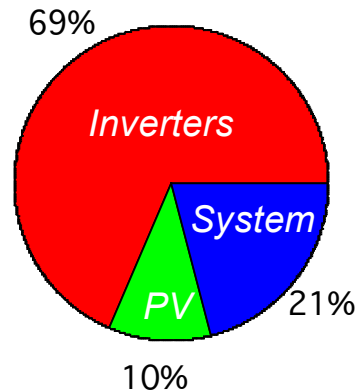
- Emerging Modules at PVUSA_Townsend_PG&E_1995.pdf
- Irradiance & Temp Effects on PV power_Whitaker_Endecon_IEEE_1991.pdf
- New performance index: PVUSA_Townsend_PG&E_IEEE_1994.pdf
- New PV performance model_Whitaker_Sandia_PVSC_1997.pdf
- Outdoor PV performance at PG&E_Jennings_PVSC_1990.pdf
- PG&E Research_Weinberg_PG&E_PVSC_1989.pdf
- PV module performance_Jennings_PVSC_1988.pdf
- PV Power performance_Wenger_PG&E_PVSC_1990.pdf
- PV research PG&E_Jennings_PG&E_PVSC_1990.pdf
- PVUSA 1st decade_Jennings_PG&E_IEEE_1996.pdf
- PVUSA beginning_Hester_PG&E_1988.pdf
- PVUSA early lessons_Hester_1996.pdf
- PVUSA for PV plant_Dows_PVUSA_1995.pdf
- PVUSA progress report 1989.pdf
- PVUSA progress report 1991.pdf

“CARRISA PLAINS PV POWER PLANT PERFORMANCE”, Wenger et al., PG&E, PVSC 1990.

Panels showed the highest maintenance

Tucson Electric Power - Springerville

“Five Years of Operating Experience at a Large, Utility-scale Photovoltaic Generating Plant”, L. M. Moore et al., Prog. Photovolt: Res. Appl. 2008; 16:249–259



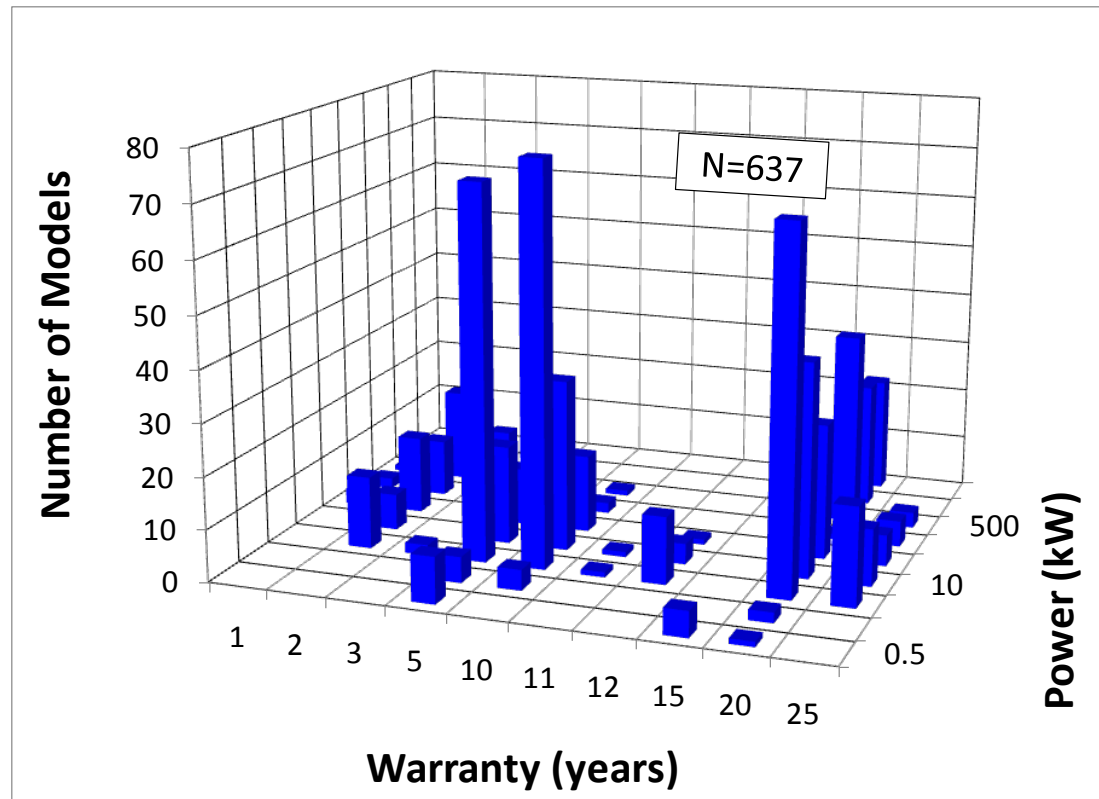
Unscheduled maintenance costs for PV system operation

| Category | No. Events (%) | Cost (%) | Notes |
|---------------|----------------|----------|----------------------------------|
| Inverter | 37 | 59 | 25% from 1 lightning storm |
| DAS | 7 | 14 | 90% from 1 lightning storm |
| AC Disconnect | 21 | 12 | 50% due to dirt accumulation |
| Module/J Box | 12 | 3 | 60% due to failed blocking diode |
| PV Array | 15 | 6 | 45 % from 1 lightning storm |
| System | 8 | 6 | All utility meter |

Module stability has improved over the last 20 years → the next component requiring improvement is the inverter.

Inverters seem to dominate O&M cost now

Maximum Warranties - Inverters



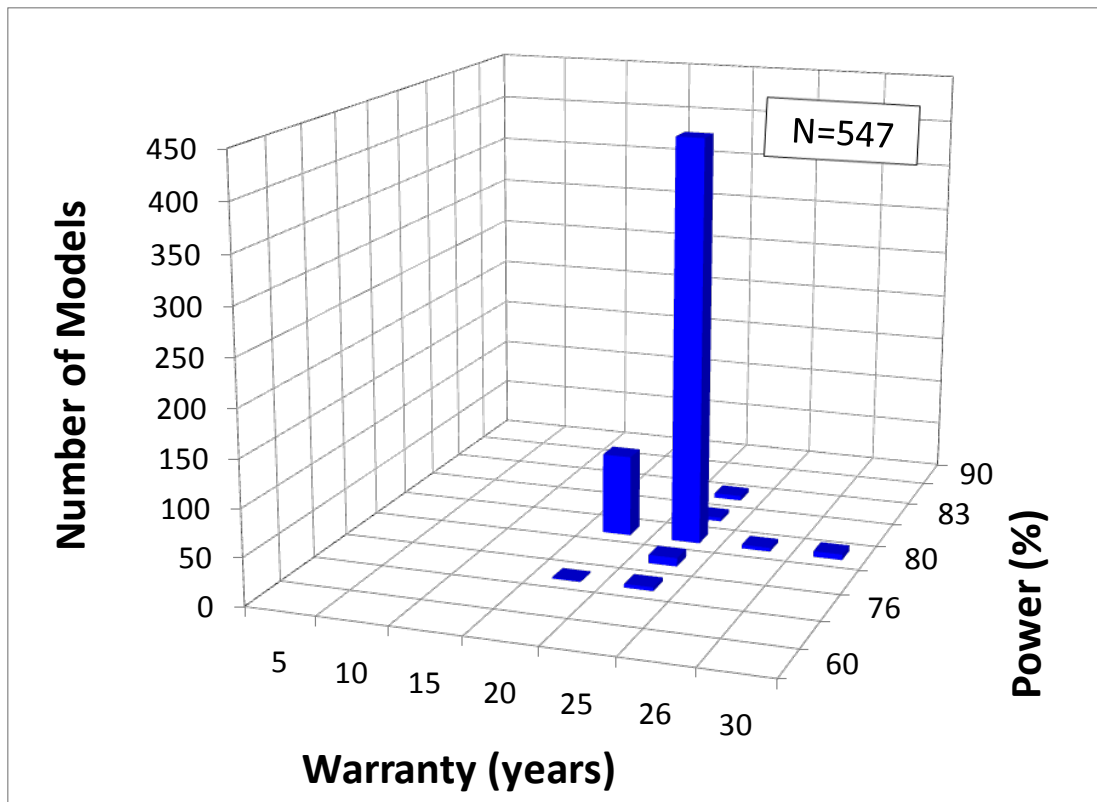
Source:
Photon International,
April 2010

Inverters suffer from early failures in the field due temperature-related issues, mismatch between PV voltage and inverter window.

Qualification and performance standards for inverters and BOS are not well-defined

Inverters are improving but still have wide distribution

Maximum Warranties - Modules



Solarex/BP module
Warranty Period

| Date | Length of Warranty |
|-------------|--------------------|
| Before 1987 | 5 Years |
| 1987 – 1993 | 10 Years |
| 1993 – 1999 | 20 Years |
| Since 1999 | 25 Years |

"Long Term Photovoltaic Module Reliability", J.Wolgemuth, NCPV and Solar Program Review Meeting 2003

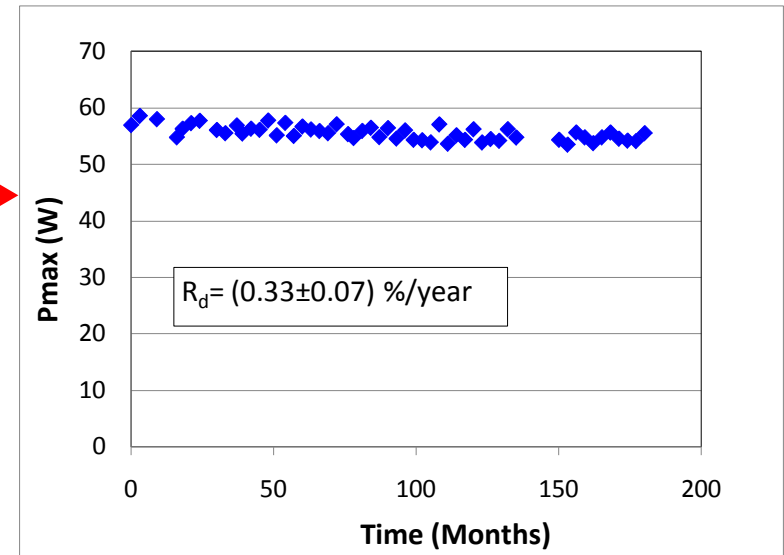
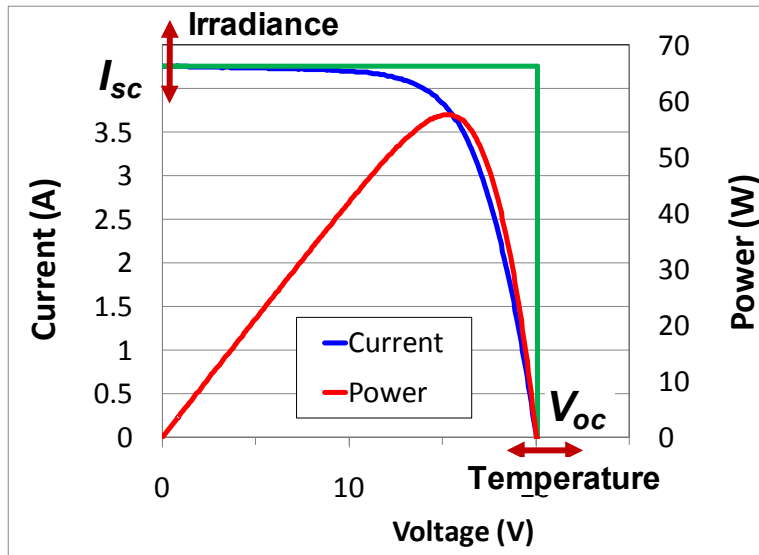
Module maximum warranties typically greater than inverters

PV modules show smaller distribution

Source:
Photon
International,
Feb 2010

Degradation Rate (R_d)- Discrete Points

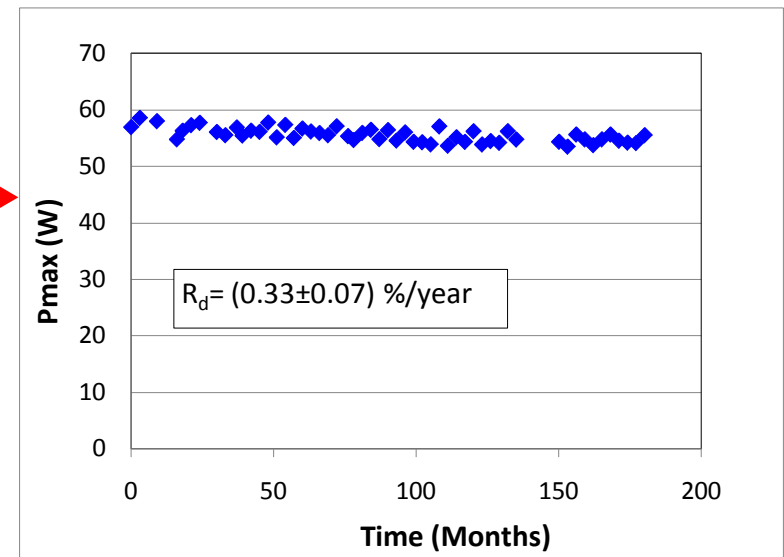
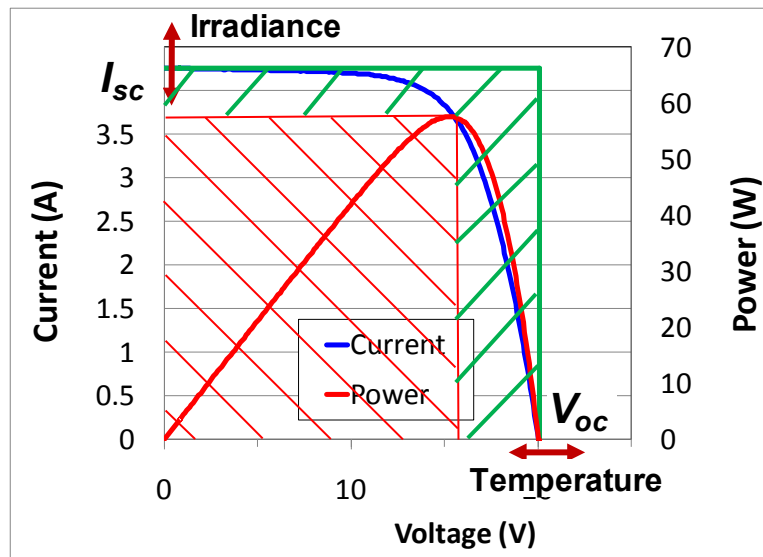
1. Translation to reference conditions (IEC60891)
2. Time series to determine degradation rate



Quarterly taken I-V curves for degradation

Degradation Rate - Discrete Points

1. Translation to reference conditions (IEC60891)
2. Time series to determine degradation rate

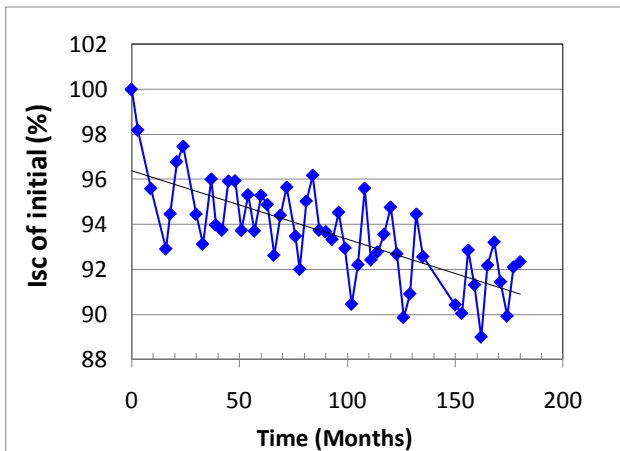


$$FF = \frac{P_{\max}}{I_{sc} \cdot V_{oc}} = \frac{I_{\max} \cdot V_{\max}}{I_{sc} \cdot V_{oc}}$$

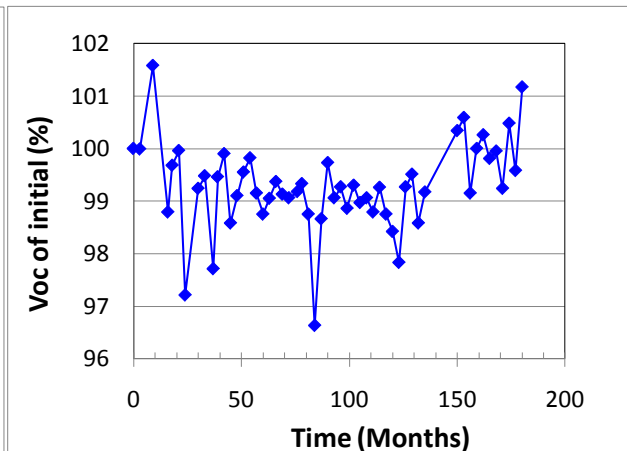
Quarterly taken I-V curves for degradation

Degradation Rate - Discrete Points

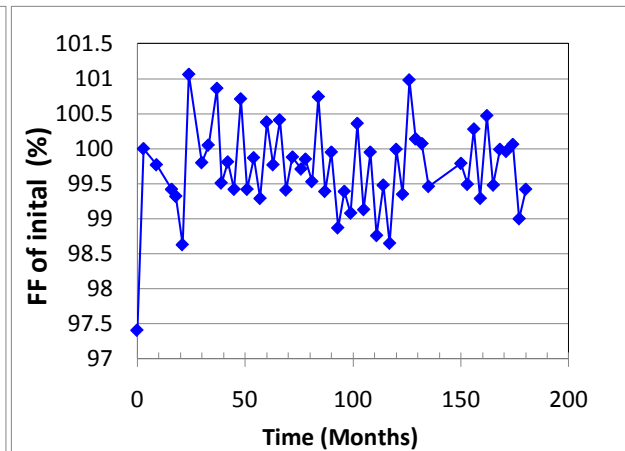
Short-circuit Current



Open-circuit Voltage



Fill Factor



Degradation is due to decline in I_{sc} , (V_{oc} & FF are stable) → clues to failure mechanism

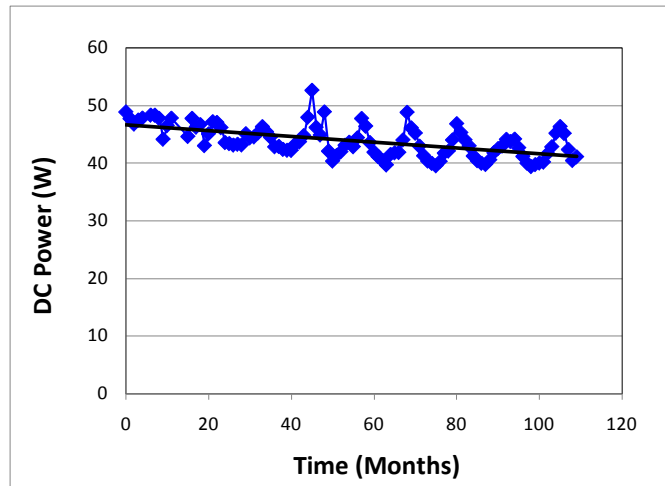
- Problem:
1. Labor-intensive, has to be clear sky
 2. Large arrays → portable I-V tracer may not be available
 3. Typically not available

I-V curves provide clues to underlying failure mechanism

Degradation Rate - Continuous Data

1. Translation to reference conditions (use a multiple regression approach)
2. Time series to determine degradation rate

DC, AC Power



PVUSA – multiple regression

$$P = E \cdot (a_1 + a_2 \cdot E + a_3 \cdot T_{ambient} + a_4 \cdot ws)$$

Standard Test Conditions (STC): $E=1000 \text{ W/m}^2$, $T_{module}=25^\circ\text{C}$

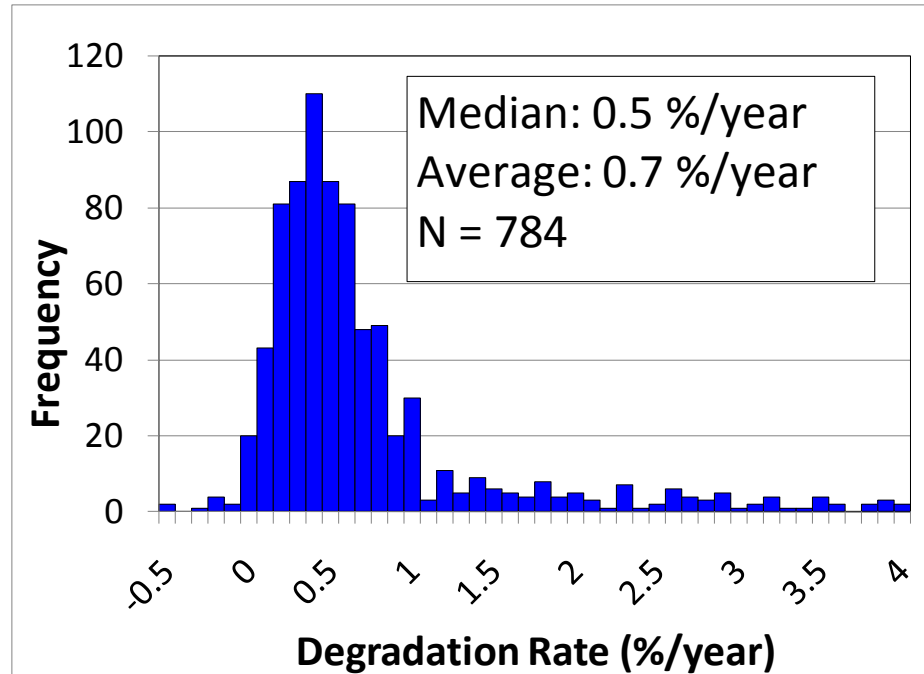
PVUSA Test Conditions (PTC): $E=1000 \text{ W/m}^2$, $T_{ambient}=20^\circ\text{C}$, wind speed=1 m/s

Seasonality leads to required observation times of 3-5 years → long time in today's market

Long time required for accurate R_d

Historical Degradation Rates

Published R_d in literature



Technology, age,
packaging, geographic
location

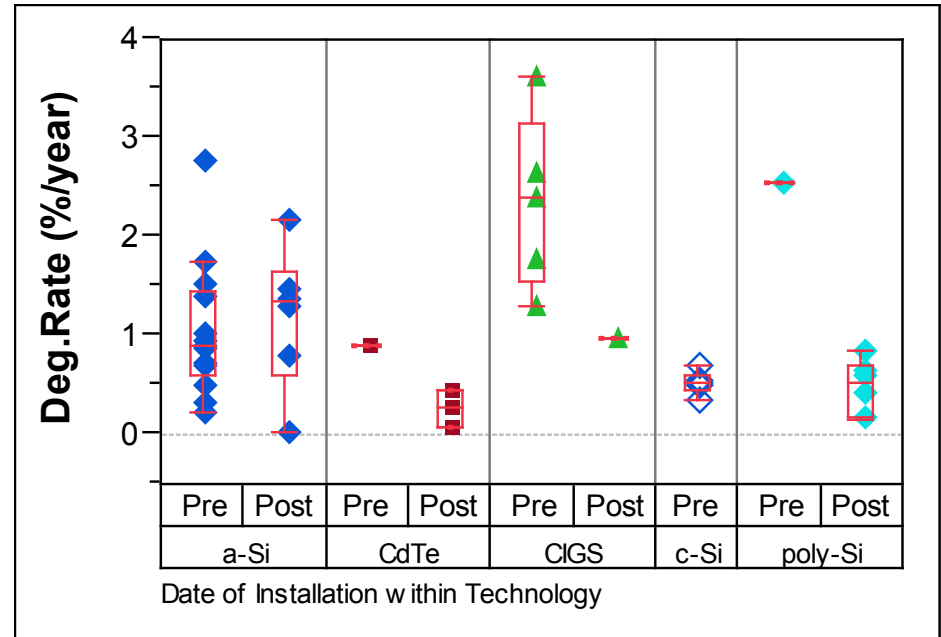
Most modules degrade by ca. 0.5 %/year

PERT – Degradation Rates

Performance Energy Rating Testbed =
PERT

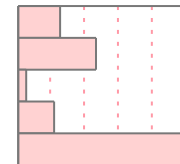


More than 40 Modules,
> 10 manufacturers,
Monitoring time: 2 yrs-16 yrs



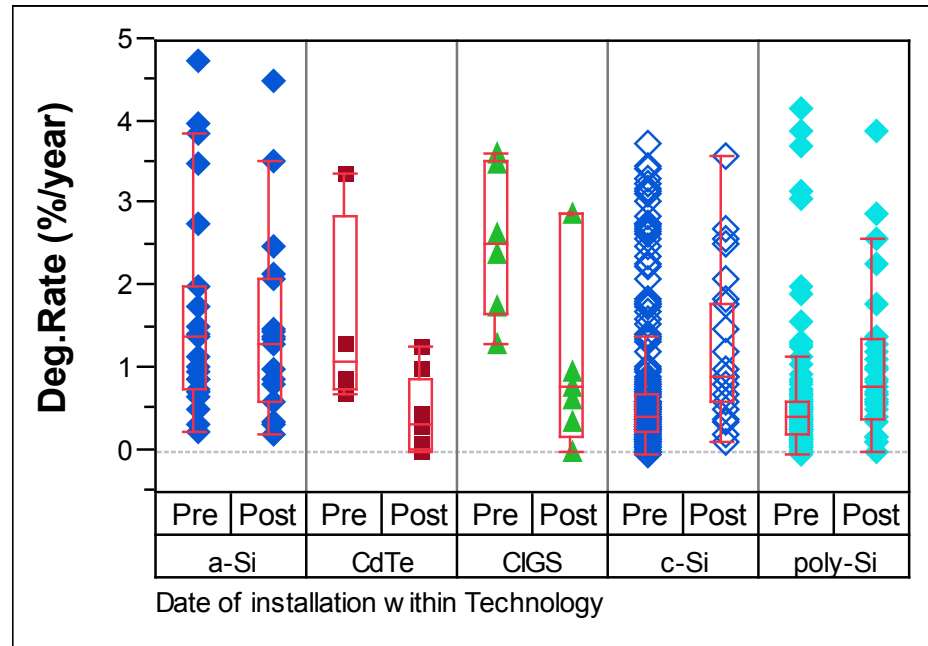
Pre: Installed before year 2000

Post: Installed after year 2000



Appears that CdTe, CIGS & poly-Si improved

Historical Degradation Rates



Historical degradation rates are analyzed in a similar way

Similar tendency found as with the PERT modules

While the Si technologies remain stable, thin-films seem to have improved.

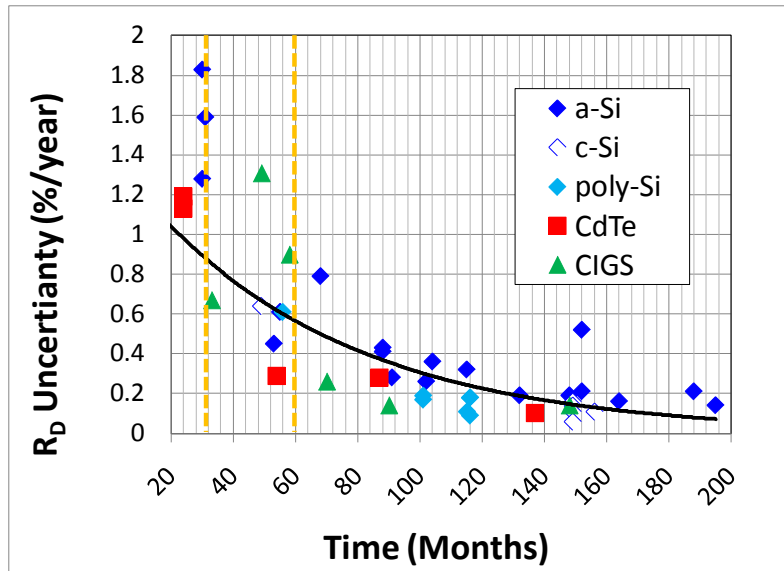
c-Si and Poly-Si show an uptick in $R_d \rightarrow$ could be from new manufactures pushing into market*

*G. TamizhMani et al., "Failure Analysis of Module Design Qualification Testing", Proc. 35th PVSC, Honolulu, HI, June 20-25 2010.

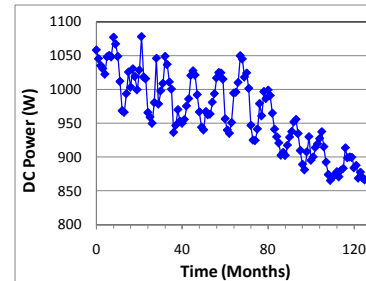
Appears that CdTe, CIGS & poly-Si improved

Degradation Rate Uncertainty

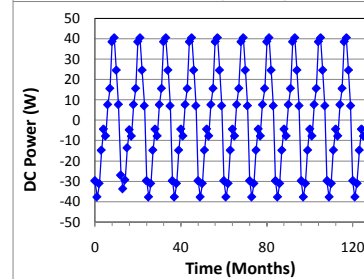
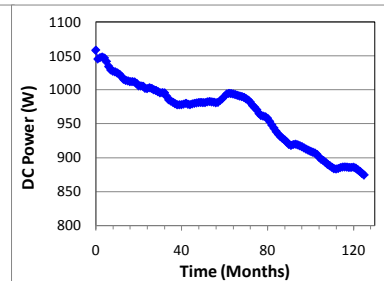
PERT Data



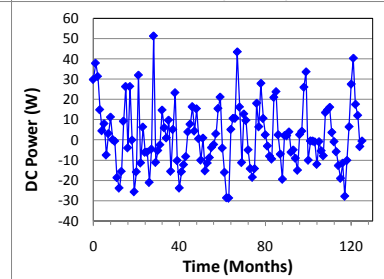
Original



Trend



Seasonality



Irregular

Traditionally: need 3-5 years to determine R_d^* .

Modeling: (i) Classical Decomposition
(ii) ARIMA**

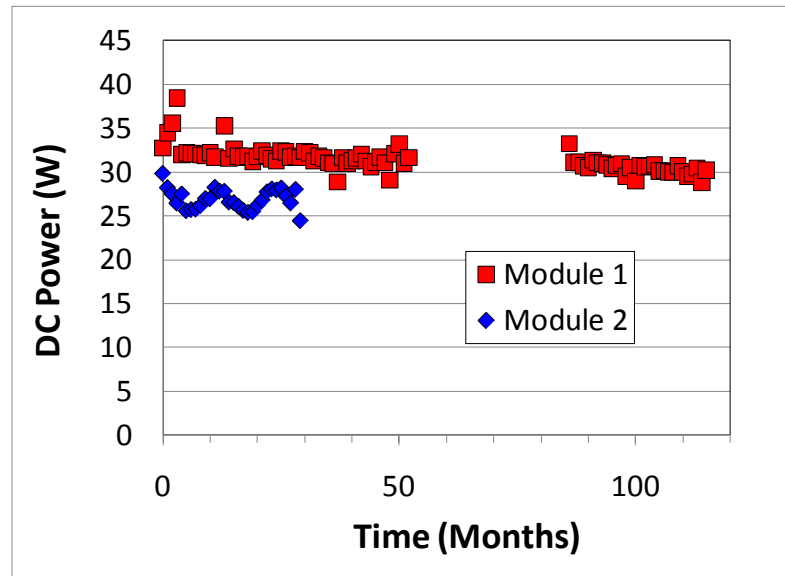
Accurate Determination of R_d takes time

Modeling can shorten required time

*Osterwald CR, Adelstein J, del Cueto JA, Kroposki B, Trudell D, Moriarty T. Proc. of the 4th IEEE World Conference on Photovoltaic Energy Conversion, Hawaii, 2006.

** D.C.Jordan et al., "Analytical Improvements in PV Degradation Rate Determination", Proc. 35th PVSC, Honolulu, HI, June 20-25 2010.

Consequences of R_d Uncertainty



2 examples from NREL:

Different observation lengths, seasonality etc. → Leads to different uncertainties

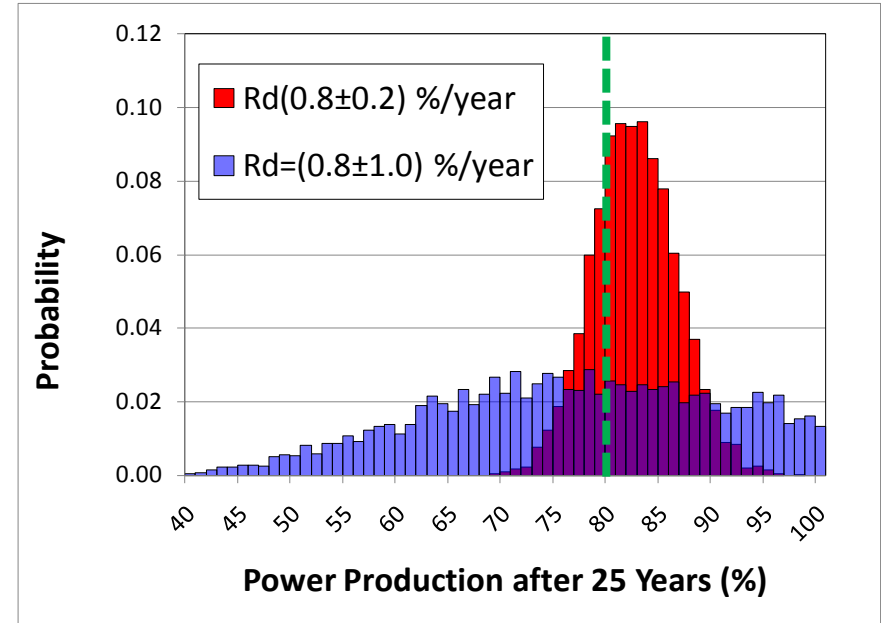
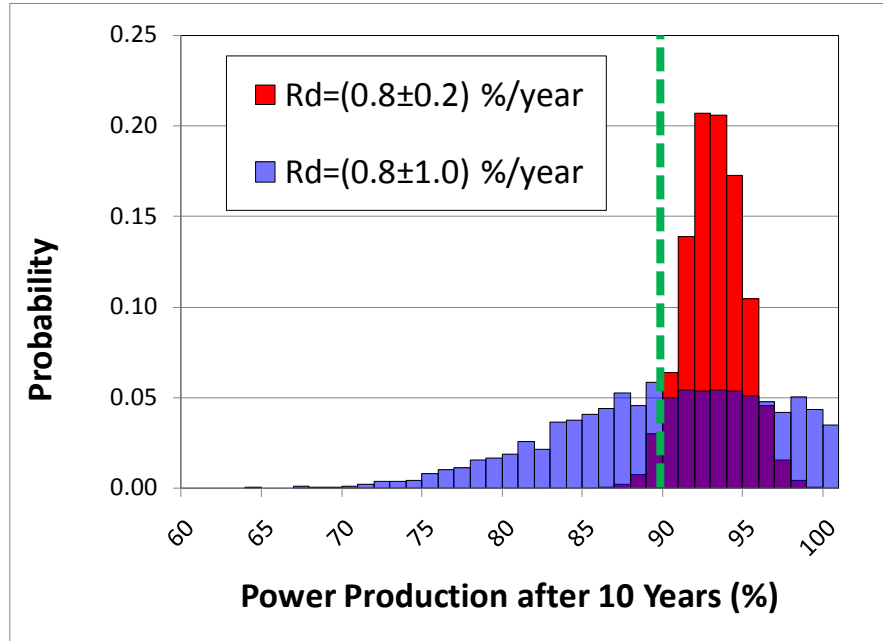
$$R_d (\text{Module 1}) = (0.8 \pm 0.2) \%/\text{year}$$

$$R_d (\text{Module 2}) = (0.8 \pm 1.0) \%/\text{year}$$

Same R_d but very different uncertainty

R_D Uncertainty Impact on Warranty

Manufacturer Warranty often twofold: 90% after 10 years, 80% after 25 years



Probability to invoke warranty:

$$Energy(Year_N) = \sum_{n=1}^N \frac{Energy(Year_1) \cdot (1 - R_D)^n}{(1 + r)^n}$$

1.0 %/year uncertainty = 46%

0.2 %/year uncertainty = 4%

Probability to invoke warranty:

1.0 %/year uncertainty = 57%

0.2 %/year uncertainty = 24%

Higher R_D uncertainty significantly increases warranty risk

Thank You!